


<b>Search Notes</b>  	<b>Application/Control No.</b>  10651428	<b>Applicant(s)/Patent Under Reexamination</b>  XIE, FEI
	<b>Examiner</b>  YUWEN PAN	<b>Art Unit</b>  2618

SEARCHED			
Class	Subclass	Date	Examiner
455	412.1, 412.2	12/17/08	YP

SEARCH NOTES		
Search Notes	Date	Examiner
EAST text search	12/17/08	YP
updated search	3/5/09	YP

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
	see search history	9/29/09	YP

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